



Accredited testing-laboratory

DAR registration number: DAT-P-176/94-D1

**Federal Motor Transport Authority (KBA)
DAR registration number: KBA-P 00070-97**

Recognized by the Federal Communications Commission

Anechoic chamber registration no.: 90462 (FCC)

Anechoic chamber registration no.: 3463A-1 (IC)

Certification ID: DE 0001

Accreditation ID: DE 0002

Accredited Bluetooth® Test Facility (BQTF)

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Test report no. : 2-4839-02-07/07

Type identification : TEKConnect

Applicant : SIEMENS Audiologische Technik GmbH

FCC ID : SGI-WL200AP

IC Certification No : 267AB-WL200AP

Test standards : FCC Part 15.247

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1 General information

1.1 Notes

The test results of this test report relate exclusively to the test item specified in 1.5. The CETECOM ICT Services GmbH does not assume responsibility for any conclusions and generalisations drawn from the test results with regard to other specimens or samples of the type of the equipment represented by the test item. The test report may only be reproduced or published in full. Reproduction or publication of extracts from the report requires the prior written approval of the CETECOM ICT Services GmbH.

Test laboratory manager:

2008-02-28 **Warken Jörg**

Date Name Signature

2008-02-28 **Ames Harro**

Date Name Signature

Technical responsibility for area of testing:

2008-02-28 **Warken Jörg**

Date Name Signature

1.2 Testing laboratory

CETECOM ICT Services GmbH

Untertürkheimer Straße 6 - 10

66117 Saarbrücken

Germany

Phone: + 49 681 5 98 - 0

Fax: + 49 681 5 98 - 9075

e-mail: info@ICT.cetecom.de

Internet: <http://www.cetecom-ict.de>

State of accreditation: The test laboratory (area of testing) is accredited according to
DIN EN ISO/IEC 17025
DAR registration number: DAT-P-176/94-D1

Accredited by: Federal Motor Transport Authority (KBA)
DAR registration number: KBA-P 00070-97

Testing location, if different from CETECOM ICT Services GmbH:

Name :
Street :
Town :
Country :
Phone :
Fax :

1.3 Details of applicant

Name:	SIEMENS Audiologische Technik GmbH Basic Technology (AEBT)
Street:	Gebbertstrasse 125
Town:	91058 Erlangen
Country:	Germany
Telephone:	
Fax:	+49-9131-308-3502
Contact:	Herrn Michael Hanisch
E-mail:	michael.hanisch@siemens.com
Telephone:	+49-9131-308-3615

1.4 Application details

Date of receipt of order:	2008-01-30
Date of receipt of test item:	2008-01-30
Date of start test:	2008-01-30
Date of end test	2008-02-28

Persons(s) who have been present during the test: --

2 Test standard/s:

FCC Part 15 §15.247 - CANADA RSS-210

3 Technical tests

3.1 Details of manufacturer

Name:	SIEMENS Audiologische Technik GmbH Basic Technology (AEBT)
Street:	Gebbertstrasse 125
Town:	91058 Erlangen
Country:	Germany

3.1.1 Test item

Kind of test item	:	remote control 1
Type identification	:	TEKConnect
S/N serial number	:	001BFB1A4895 (conducted) 001BFB1A4883 (radiated)
HW hardware status	:	6.0
SW software status	:	2.7
Frequency Band [MHz]	:	ISM 2.400 - 2.483,5
Type of Modulation	:	FHSS
Number of channels	:	79
Antenna	:	integral
Power Supply	:	3.9V (3.6V-4.2V)
Temperature Range	:	-20°C to 55°C

Max. power radiated: -2.29 dBm (EIRP)

Max. power conducted: -2.94 dBm

FCC ID: SGI-WL200AP

IC: 267AB-WL200AP

3.1.2 Description of the test

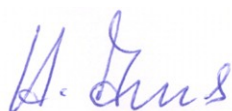
-/-

3.1.3 Additional EUT information For IC Canada (appendix 2)

IC Registration Number:	267AB-WL200AP
Model Name:	TEKConnect
Manufacturer (complete Address):	SIEMENS Audiologische Technik GmbH Gebbertstrasse 125 91058 Erlangen Germany
Tested to Radio Standards Specification (RSS) No.:	RSS-210 Issue 7
Open Area Test Site Industry Canada Number:	IC 3463A-1
Frequency Range (or fixed frequency) [MHz]:	2400 – 2483.5 MHz
RF: Power [W] (max):	Rad. EIRP: 0.59 mW Conducted : 0.51 mW
Antenna Type:	integral
Field Strength [dBμV/m in 3m]:	92.9
Occupied Bandwidth (99% BW) [kHz]:	872
Type of Modulation:	FSK
Emission Designator (TRC-43):	872KFXD / 79M0FXD (FHSS)
Transmitter Spurious (worst case) [μV/m in 3m]:	38.2
Receiver Spurious (worst case) [μV/m in 3m]:	40

ATTESTATION: I attest that the testing was performed or supervised by me; that the test measurements were made in accordance with the above-mentioned departmental standard(s), and that the radio equipment identified in this application has been subject to all applicable test conditions specified in the departmental standards and all of the requirements of the standards have been met.

Signature:



Date: 2008-02-27

Test engineer: Ames Harro

3.1.4 EUT operating modes

EUT operating mode no. *)	Description of operating modes	Additional information
Op. 0	Normal mode	Normal temperature and power source conditions
Op. 1		low temperature, low power source conditions
Op. 2		low temperature, high power source conditions
Op. 3		high temperature, low power source conditions
Op. 4		high temperature, high power source conditions

*) EUT operating mode no. is used to simplify the test plan

3.1.5 Extreme conditions testing values

Description	Shortcut	Unit	Value
Nominal Temperature	T _{nom}	°C	20
Nominal Humidity	H _{nom}	%	60
Nominal Power Source	V _{nom}	V	3.9

Type of power source: **DC**

Deviations from these values are reported in chapter 2

4 Summary of Measurement Results and list of all performed test cases

- ☒ No deviations from the technical specifications were ascertained
☐ There were deviations from the technical specifications ascertained

TC identifier	Description		verdict	date		Remark	
RF-Testing	FCC Part 15 §15.247 - CANADA RSS-210		PASS	2008-02-28			
Test Specification Clause	Test Case	Modulation	Pass	Fail	N/A	Not performed	
None	Antenna Gain	GFSK	Yes				
§15.247(a1)	Carrier frequency separation	GFSK	Yes				
§15.247(a1)	Number of hopping channels	GFSK	Yes				
§15.247(a)(1)(iii)	Time of occupancy (dwell time)	--	Yes				
§15.247(e)	Power Spectral density (Hybrid system in Inquiry mode/Page scan)	--			Yes		
§15.247(a)(1)	Spectrum Bandwidth of a FHSS System / 20dB Bandwith	GFSK Pi/4 DQPSK 8 DPSK	Yes		Yes Yes		
§ 15.247 (b)(1)	Maximum output power (conducted)	GFSK Pi/4 DQPSK 8 DPSK	Yes		Yes Yes		
§ 15.247 (b)(1)	Max. peak output power (radiated)	GFSK	Yes				
§ 15.247 (d)	Band-edge compliance of conducted emissions	Widest modulation	Yes				
§ 15.205	Band-edge compliance of radiated emissions	Widest modulation	Yes				
§ 15.247 (d)	Spurious Emission - conducted (Transmitter)	GFSK	Yes				
§ 15.247 (d)	Spurious Emission - radiated (Transmitter) >30 MHz	GFSK	Yes				
§ 15.109	Spurious Emissions - radiated (Receiver)	GFSK	Yes				
§ 15.209	Spurious Emissions - radiated (Transmitter) <30 MHz	GFSK	Yes				
§ 15.107/207	Conducted Emissions <30 MHz	GFSK	Yes				

5 RF measurement testing

5.1 Description of test set-up

5.1.1 Radiated measurements

The radiated measurements are performed in vertical and horizontal plane in the frequency range from 9 kHz to 25 GHz in semi-anechoic chambers. The EUT is positioned on a non-conductive support with a height of 0.80 m above a conductive ground plane that covers the whole chamber. The receiving antennas are confirmed with specifications ANSI C63.2-1996 clause 15 and ANSI C63.4-2003 clause 4.1.5. These antennas can be moved over the height range between 1.0 m and 4.0 m in order to search for maximum field strength emitted from EUT. The measurement distances between EUT and receiving antennas are indicated in the test setups for the various frequency ranges. For each measurement, the EUT is rotated in all three axes until the maximum field strength is received. The wanted and unwanted emissions are received by spectrum analysers where the detector modes and resolution bandwidths over various frequency ranges are set according to requirement ANSI C63-4-2003 clause 4.2.

Antennas are confirmed with ANSI C63.2-1996 item 15.

9 kHz - 150 kHz: Quasi Peak measurement, 200 Hz Bandwidth, passive loop antenna.

150 kHz - 30 MHz: Quasi Peak measurement, 9 kHz Bandwidth, passive loop antenna.

30 MHz - 200 MHz: Quasi Peak measurement, 120 kHz Bandwidth, biconical antenna

200MHz - 1GHz: Quasi Peak measurement, 120 kHz Bandwidth, log periodic antenna

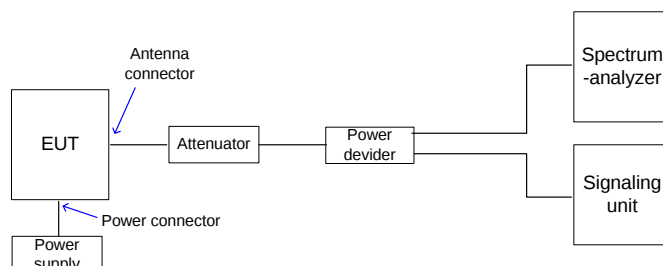
>1GHz: Average, RBW 1MHz, VBW 10 Hz, waveguide horn

All measurements are done in accordance with the Filing and Measurement Guidelines for Frequency Hopping Spread Spectrum Systems DA 00-705 and Appendix A "BLUETOOTH APPROVALS"

The EUT is powered by an external power supply with nominal voltage. The signalling is performed from outside the chamber with a signalling unit (CMU200 or other) by air link using signalling antenna.

5.1.2 Conducted measurements

The EUT's RF signal is coupled out by the antenna connector which is supplied by the manufacturer. The signal is first 10dB attenuated before it is power divided (~6dB loss per branch). One of the signal path is connected to the communication base Station (CMU200 or other), the other one is connected to the spectrum analyzer. The specific losses for both signal paths are first checked within a calibration. The measurement readings on the signalling unit/spectrum analyzer are corrected by the specific test set-up loss. The attenuator, power divider, signalling unit and the spectrum analyzer are impedance matched on 50 Ohm.



5.2 Referenced documents

None

5.3 Additional comments

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5.4 Antenna gain

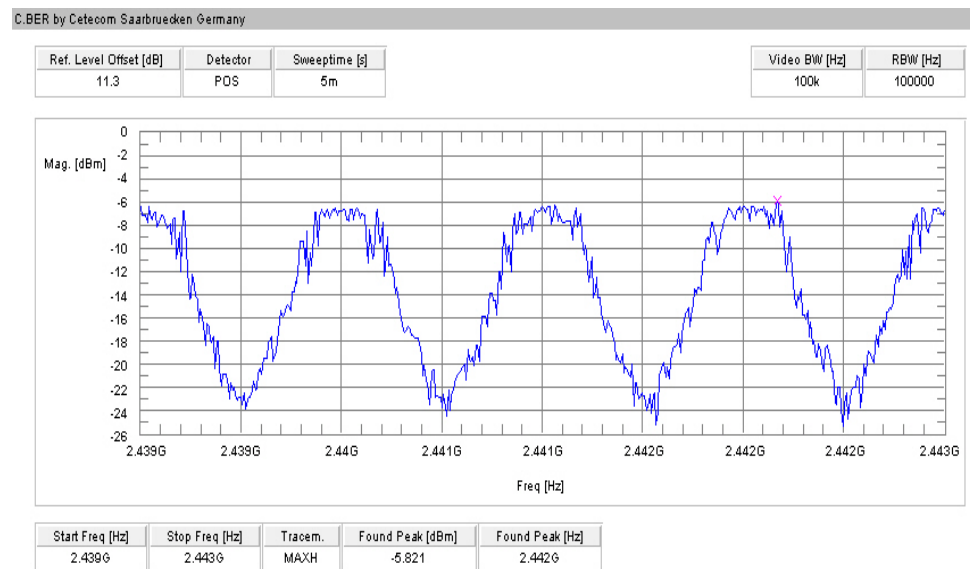
The antenna gain of the complete system is calculated by the difference of radiated power in EIRP and the conducted power of the module.

	low channel	mid channel	high channel
Conducted power [dBm]	-5.42	-4.16	-2.94
Radiated power [dBm]	-4.61	-3.39	-2.29
Gain [dBi]	0.81	0.77	0.65

5.5 Carrier frequency separation §15.247(a)(1)

Modulation: GFSK

Plot 1 of 1:



Result: Channel separation is: ~ 1 MHz

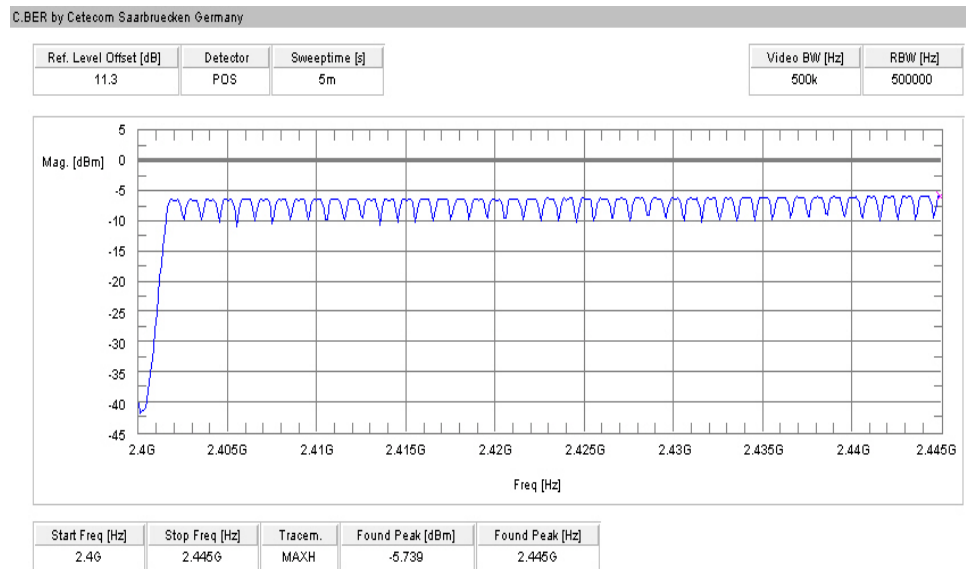
Limits:

Under normal test conditions only	Minimum 25 kHz or 20 dB Bandwidth of the hopping system
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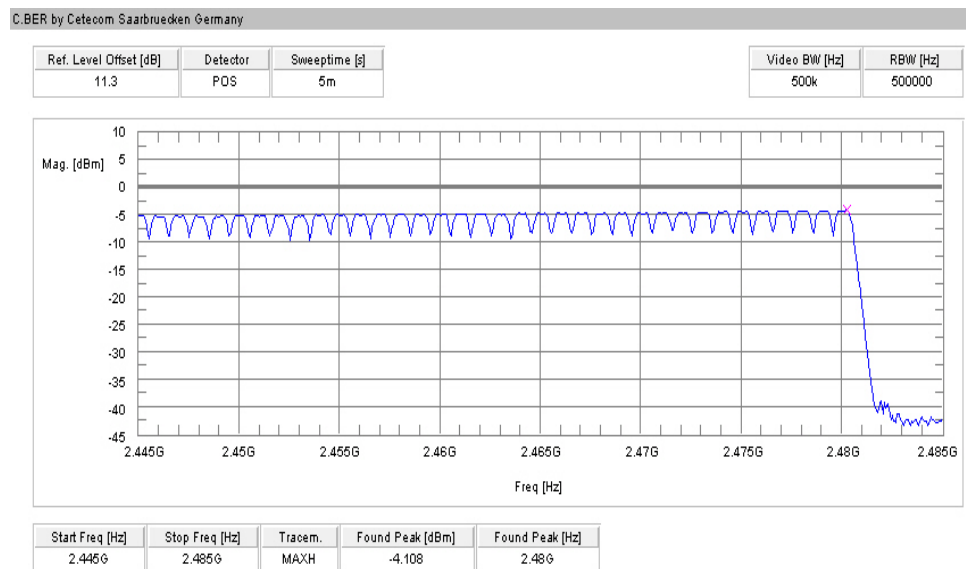
5.6 Number of hopping channels §15.247(a)(1)

Modulation: GFSK

Plot 1 of 2:



Plot 2 of 2:



Result : The number of hopping channels is: 79

Limits :

Under normal test conditions only	at least 15 non-overlapping channels
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5.7 Time of occupancy (dwell time) §15.247(a)(1)(iii)

For Bluetooth devices:

The dwell time of 0.4 s within a 31.6 second period in data mode is independent from the packet type (packet length).
The calculation for a 31.6 second period is as follows:

Dwell time = time slot length * hop rate / number of hopping channels * 31.6 s

Example for a DH1 packet (with a maximum length of one time slot)

Dwell time = $625 \mu\text{s} * 1600 \text{ 1/s} / 79 * 31.6 \text{ s} = 0.4 \text{ s}$ (in a 31.6 s period)

For multi-slot packet the hopping is reduced according to the length of the packet.

Example for a DH5 packet (with a maximum length of five time slots)

Dwell time = $5 * 625 \mu\text{s} * 1600 * 1/5 * 1/s / 79 * 31.6 \text{ s} = 0.4 \text{ s}$ (in a 31.6 s period)

This is according to the Bluetooth Core Specification V 1.1 & V 1.2 & V2.0 (+ critical errata) for all Bluetooth devices.

Therefore, all Bluetooth devices comply with the FCC dwell time requirement in the data mode.

This was checked during the Bluetooth Qualification tests.

The Dwell time in hybrid mode is approximately 2.6 ms (in a 12.8s period)

5.8 Power Spectral density (Hybrid system in Inquiry mode/Page scan) §15.247(e)

Plot 1 of 1:

Not applicable

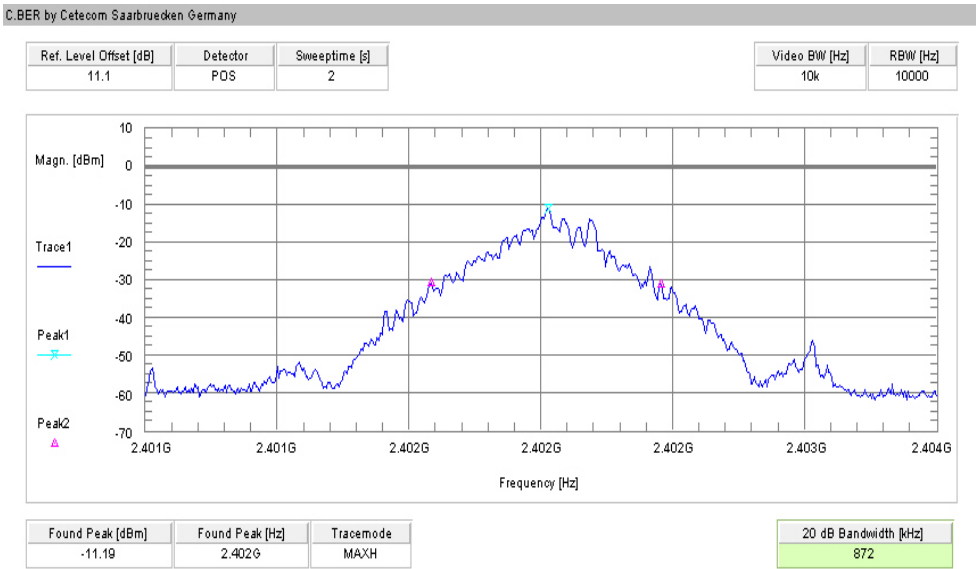
Result: Power density: - dBm/Hz = - dBm / 3 kHz
Correction factor from dBm/Hz to dBm / 3 kHz is +34,8 dB

Limits :

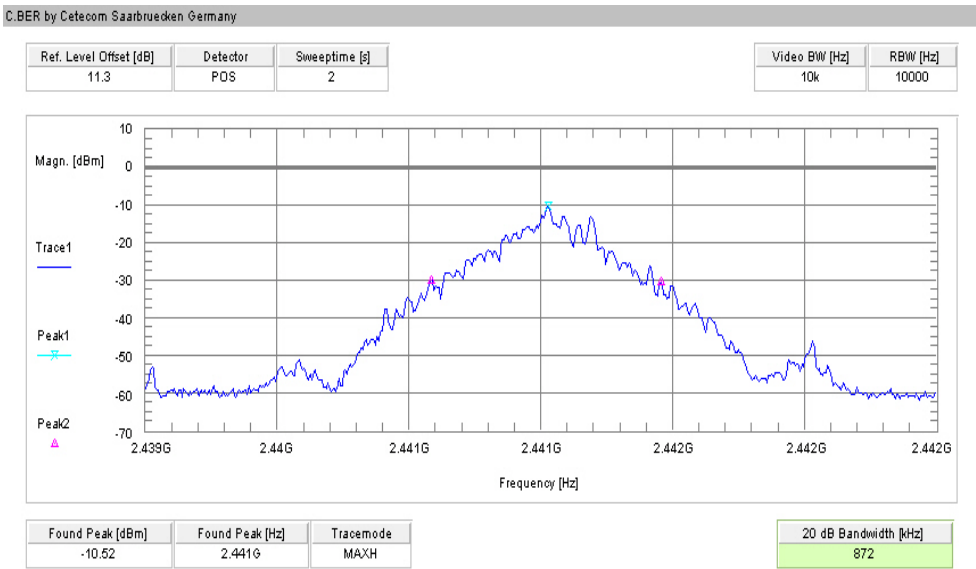
Under normal test conditions only	For digitally modulated systems, the peak power spectral density conducted from the intentional radiator to the antenna shall not be greater than 8 dBm in any 3 kHz band during any time interval of continuous transmission
-----------------------------------	---

5.9 Spectrum Bandwidth of a FHSS System / 20dB Bandwidth §15.247(a)(1)

Plot 1 GFSK

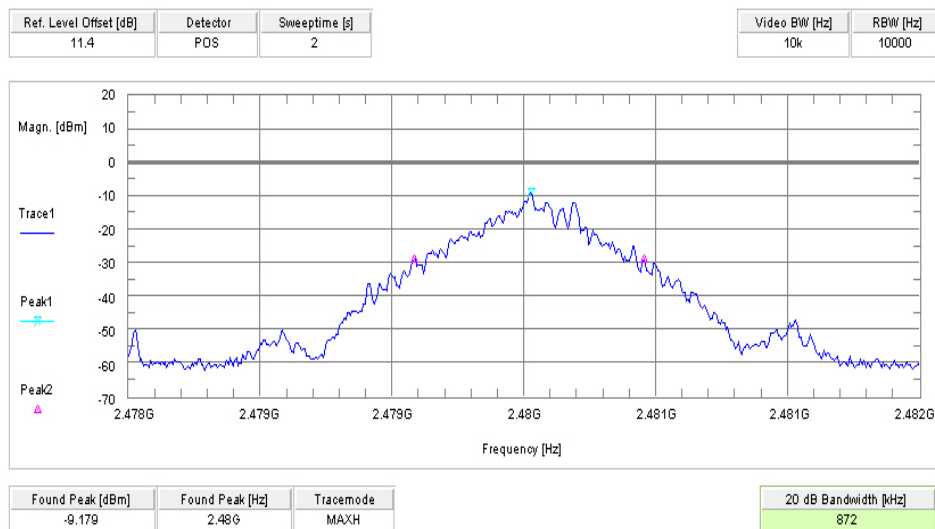


Plot 2 GFSK



Plot 3 GFSK

C.BER by Cetecom Saarbruecken Germany



RESULTS:

Modulation	20 dB BANDWIDTH [kHz]		
	2402	2441	2480
Frequency [MHz]			
GFSK	872	872	872
Pi/4 DQPSK	--	--	--
8DPSK	--	--	--
Measurement uncertainty	±1kHz		

RBW / VBW as provided in the „Measurement Guidelines“ (DA 00-705, March 30, 2000)

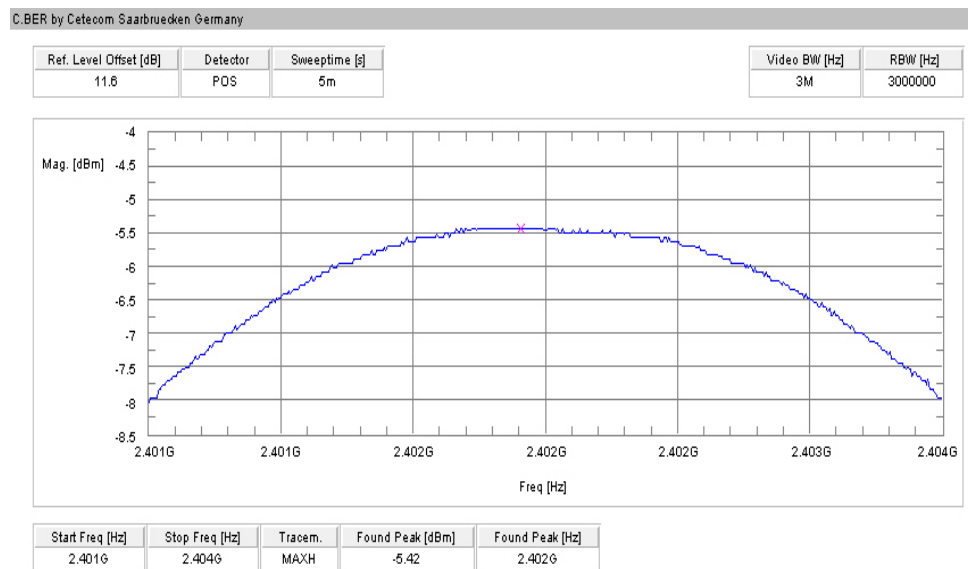
RBW: 10 kHz / VBW 10 kHz

Limits:

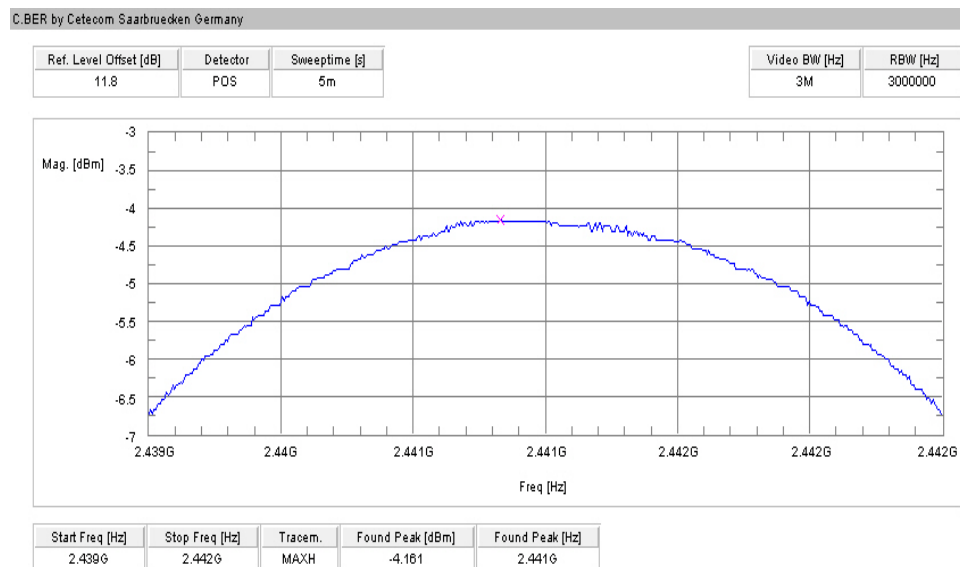
Under normal test conditions only	GFSK < 1000 kHz Pi/4 DQPSK < 1500 8DPSK < 1500
-----------------------------------	--

5.10 Maximum output power (conducted) § 15.247 (b)(1)

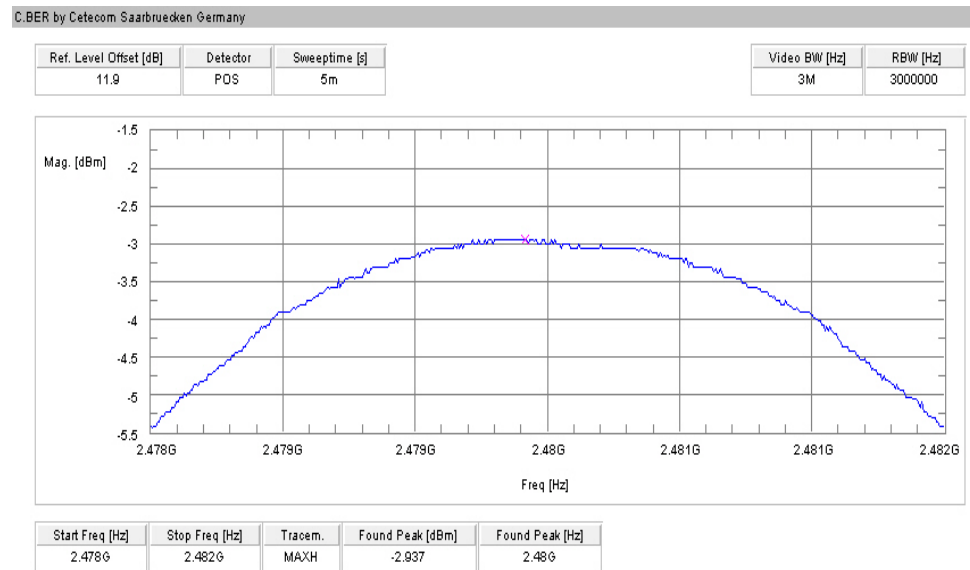
Plot 1 GFSK



Plot 2 GFSK



Plot 3 GFSK



Results:

Modulation Frequency [MHz]	Max. peak output power [dBm]		
	2402	2441	2480
GFSK	-5.42	-4.16	-2.94
Pi/4 DQPSK	--	--	--
8DPSK	--	--	--
Measurement uncertainty	±2dB		

RBW / VBW: 3 MHz

Limits:

Under normal test conditions only, for frequency range 2400-2483.5 MHz	Max. 1.0 Watt
--	---------------

5.11 Max. peak output power (radiated) § 15.247 (b)(1)Modulation: GFSK

Results:

Test conditions		Max. peak output power EIRP [dBm]		
Frequency [MHz]		2402	2442	2480
T _{nom}	V _{nom}	-4.61	-3.39	-2.29
Measurement uncertainty		±3dB		

RBW / VBW: 3 MHz

Measured at a distance of 3m

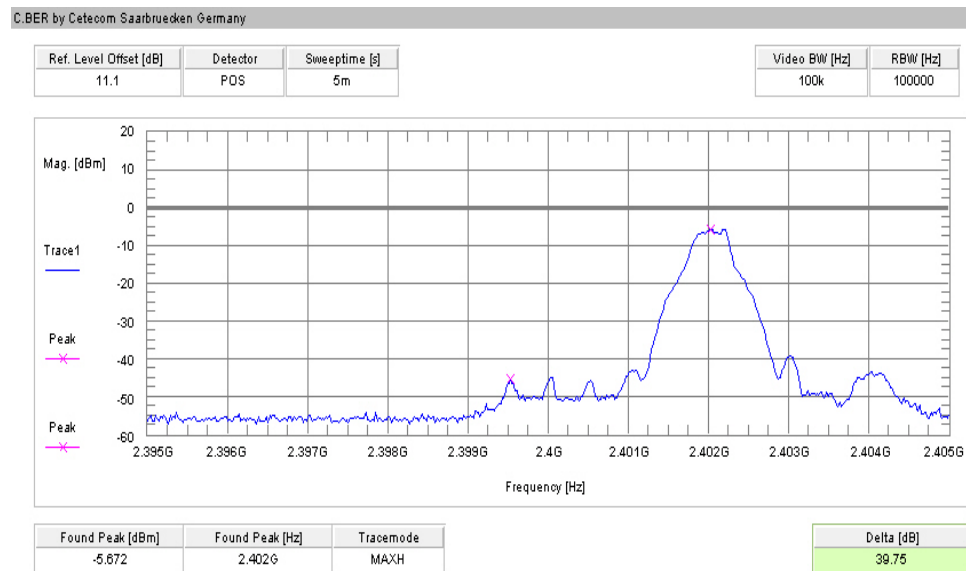
Limits:

Under normal test conditions only, for frequency range 2400-2483.5 MHz	Max. 1.0 Watt
--	---------------

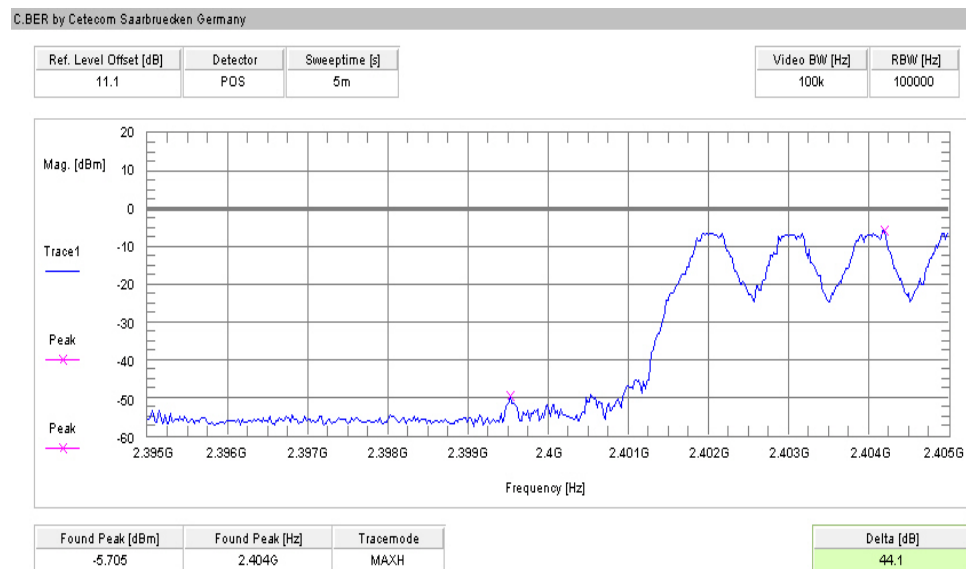
5.12 Band-edge compliance of conducted emissions §15.247 (d)

Modulation: widest

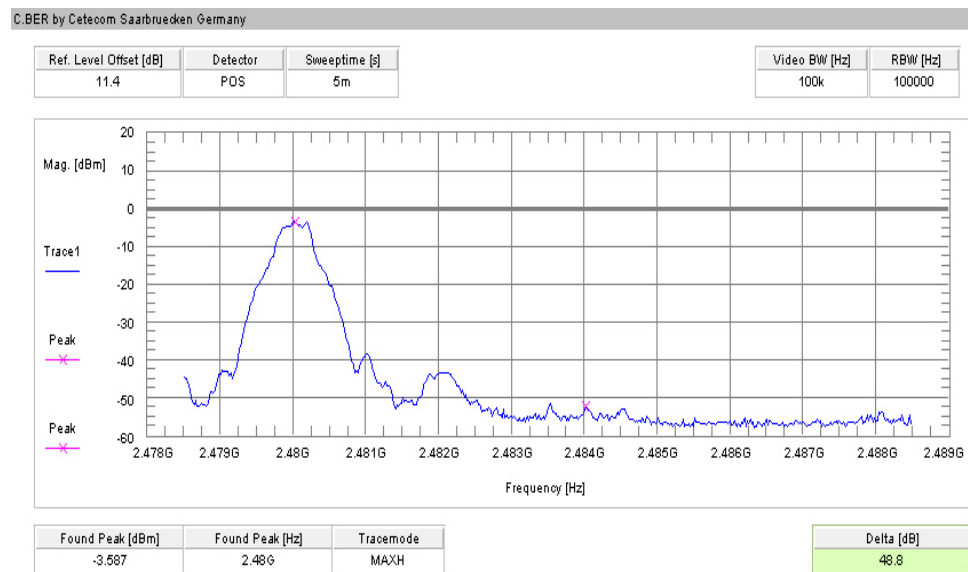
Plot 1 of 4 (hopping off, lowest frequency):



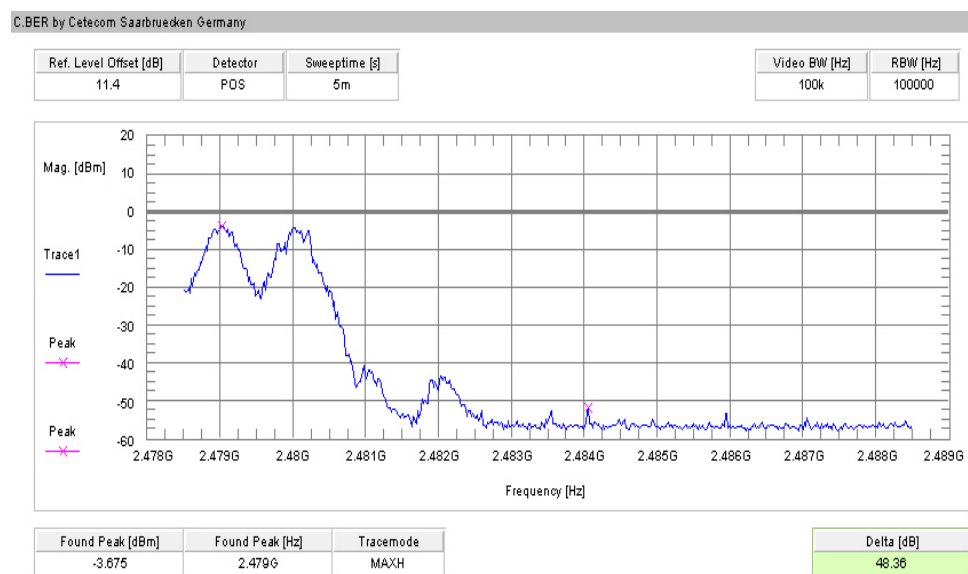
Plot 2 of 4 (hopping on, lowest frequency):



Plot 3 of 4 (hopping off, highest frequency):



Plot 4 of 4 (hopping on, highest frequency):



Results:

SZENARIO	DELTA VALUE [DB]
hopping off, lowest frequency	39.75 > 20 dB
hopping on, lowest frequency	44.10 > 20 dB
hopping off, highest frequency	48.80 > 20 dB
hopping on, highest frequency	48.36 > 20 dB
Measurement uncertainty	±1,5dB

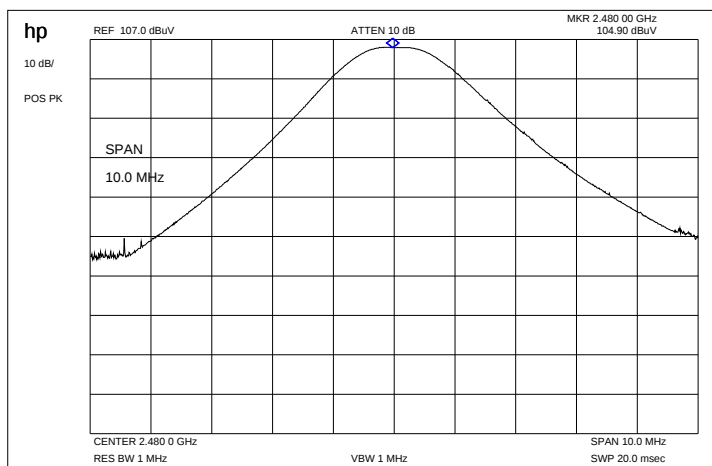
Limits:

Under normal test conditions only	In any 100 kHz bandwidth outside the frequency band in which the spread spectrum or digitally modulated intentional radiator is operating, the radio frequency power that is produced by the intentional radiator shall be at least 20 dB below that in the 100 kHz bandwidth within the band that contains the highest level of the desired power, based on either an RF conducted or a radiated measurement. Attenuation below the general limits specified in Section 15.209(a) is not required. In addition, radiated emissions which fall in the restricted bands, as defined in Section 15.205(a), must also comply with the radiated emission limits specified in Section 15.209(a) (see Section 5.205(c)).
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5.13 Band-edge compliance of radiated emissions §15.205

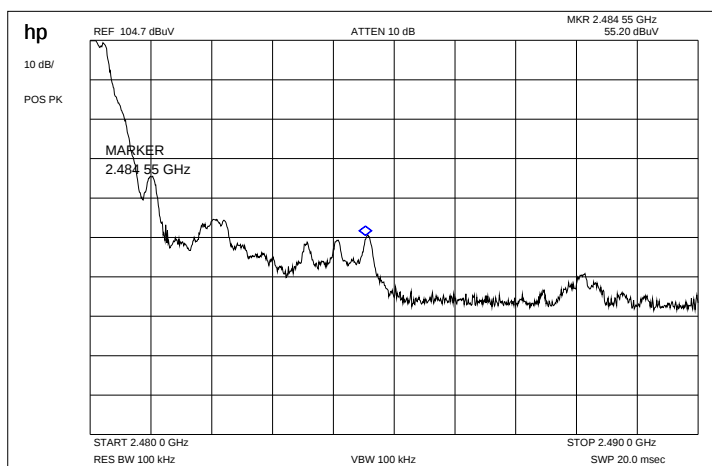
Modulation: widest

Plot 1: Max field strength in 3m distance (single frequency)



Result: 92.2 dB μ V/m (correction factor -12.7dB)

Plot 2: Marker-Delta Method (single carrier)

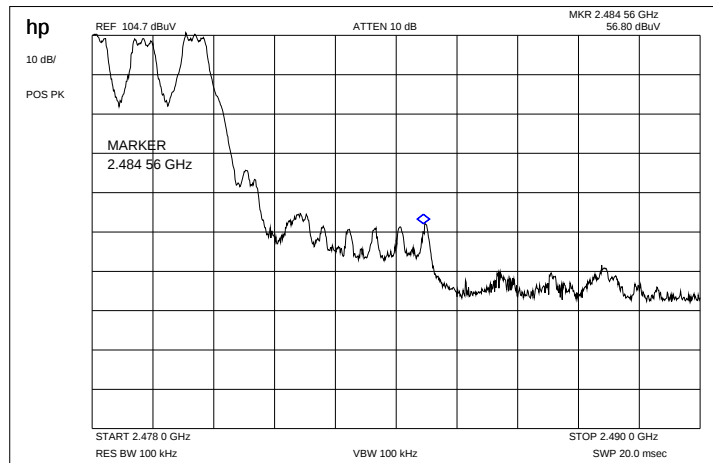


Result:

Marker-Delta-Value: 55.2 dB

This measurement was made to show that the behaviour of the system is conform to FCC 15.205 (restricted bands)

Plot 3: Marker-Delta Method (hopping)

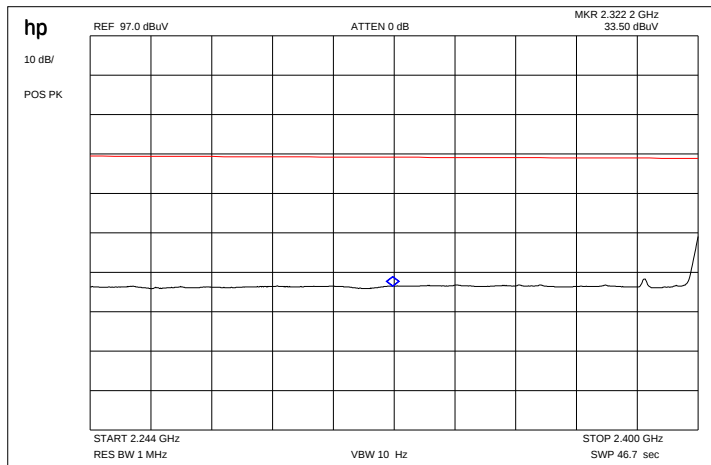


Result:

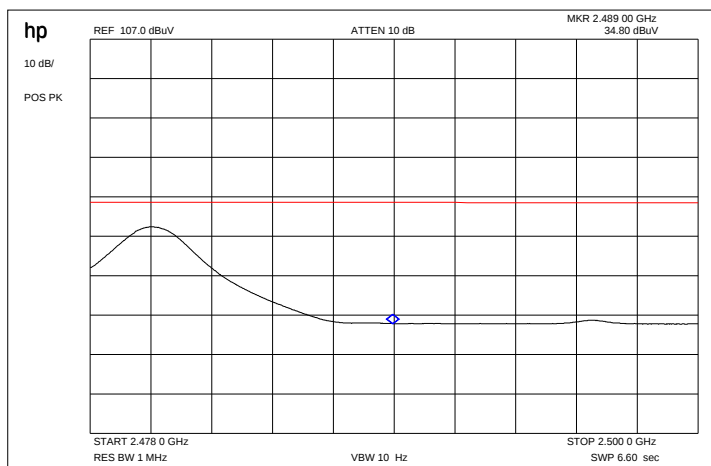
Marker-Delta-Value: 56.8 dB

This measurement was made to show that the behaviour of the system is conform to FCC 15.205 (restricted bands)

Plot 4: Restricted Bands low



Plot 5: Restricted Bands high



Results & Limits:

Radiated field strength

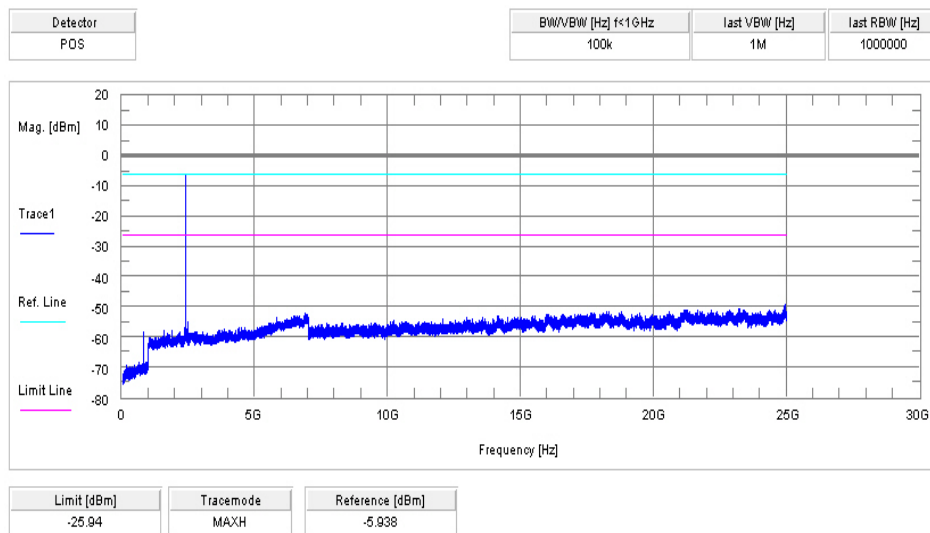
The field strength was measured with an EMI measuring receiver and 1 MHz RBW / VBW for peak and with 1MHz RBW / 10Hz VBW for average at a distance of 3m.

high channel	setup	measured value (3m)	correction factor (3m)	calculated value (3m)
Max. peak value	1 MHz RBW 1 MHz VBW	92.2 dB μ V/m	--	92.2 dB μ V/m
Max. average value	Calculated with duty cycle correction factor	92.2 dB μ V/m peak	-1.07dB duty cycle correction factor (worst case DH5)	91.13 dB μ V/m
Delta value	Peak 100 kHz RBW/VBW	55.1 dB (single carrier) 56.8 dB (hopping mode)	-	-
Value at band edge	limit 54 dB μ V/m			36.03 dB μ V/m (single carrier) 34.22 dB μ V/m (hopping mode)
Statement:				Complies

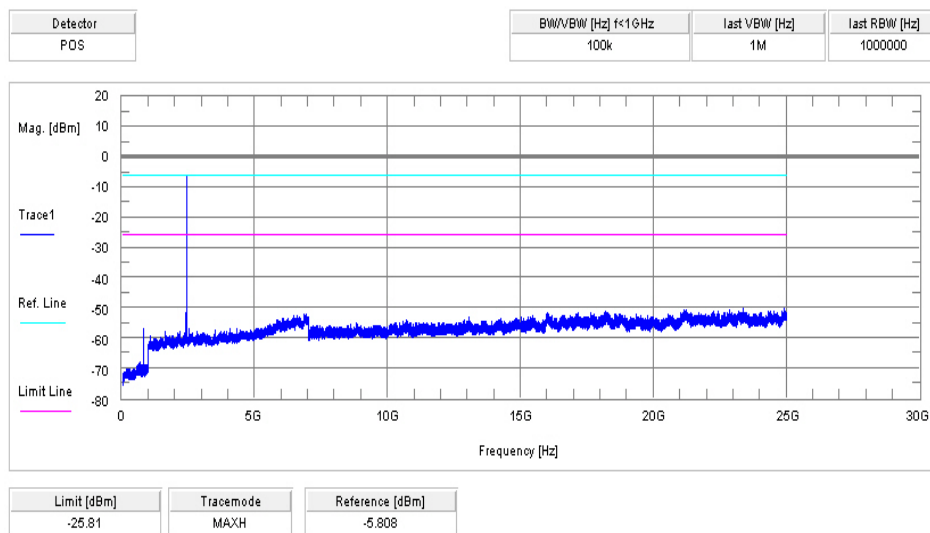
5.14 Spurious Emissions - conducted (Transmitter) § 15.247 (c)(1)

Modulation: GFSK

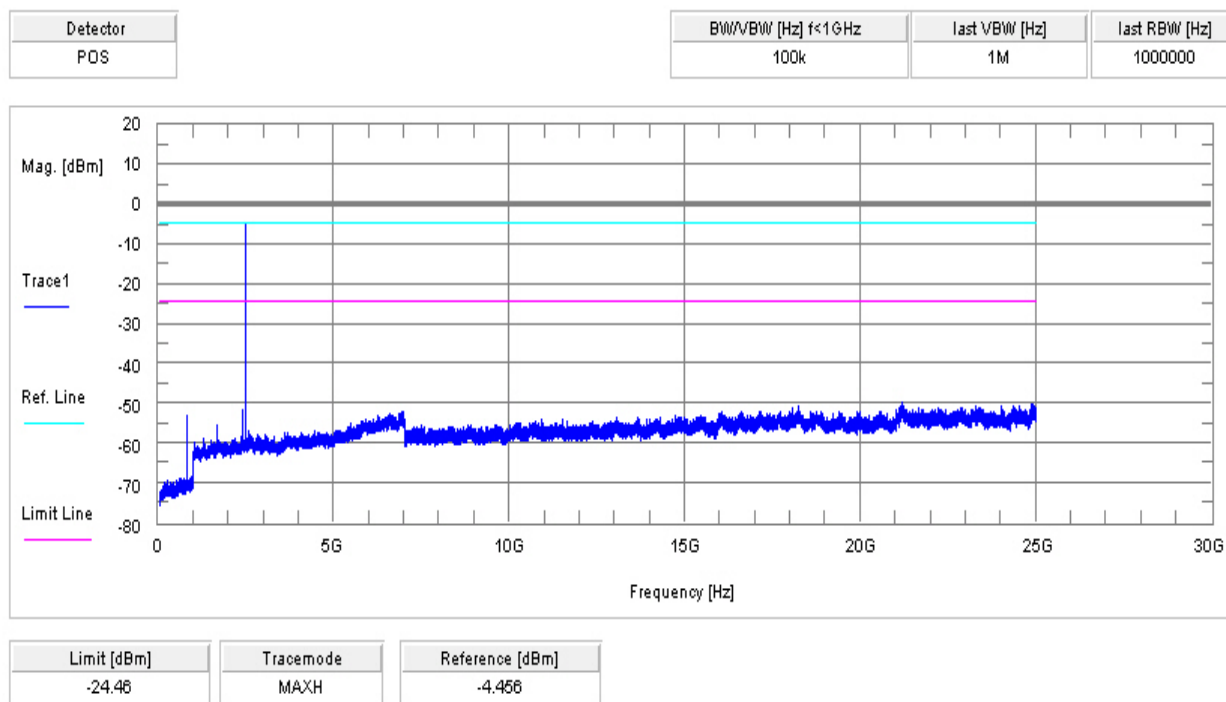
Plot 1 of 3: lowest channel



Plot 2 of 3: middle channel



Plot 3 of 3: highest channel



Result & Limits:

Emission Limitation					
f [MHz]		amplitude of emission [dBm]	limit max. allowed emmission power	actual attenuation below frequency of operation [dB]	results
2402		-5.9	30 dBm		Operating frequency
		--		--	complies
		--	-20 dBc	--	complies
2441		-5.8	30 dBm		Operating frequency
		--		--	complies
		--	-20 dBc	--	complies
2480		-4.5	30 dBm		Operating frequency
		--		--	complies
		--	-20 dBc	--	complies
Measurement uncertainty		± 3dB			

F < 1 GHz: RBW: 100 kHz VBW: 100 kHz
F > 1 GHz: RBW: 1 MHz VBW: 1 MHz

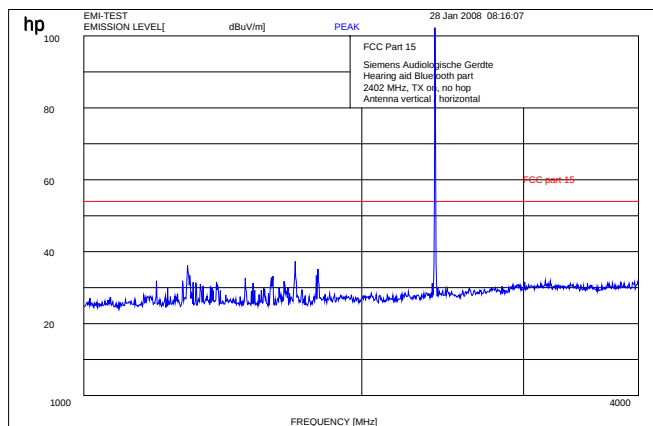
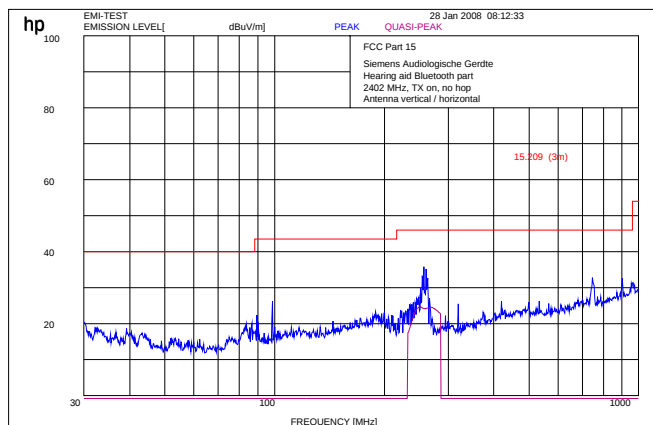
Under normal test conditions only	In any 100 kHz bandwidth outside the frequency band at least 20dB below the highest level of the desired power. In addition, radiated emissions which fall in the restricted bands, as defined in §15.205(a), must also comply with the radiated emission limits specified in §15.209(a) (see §15.205(c)).
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Note: For emissions that fall into restricted bands you find the radiated emissions later in the report.

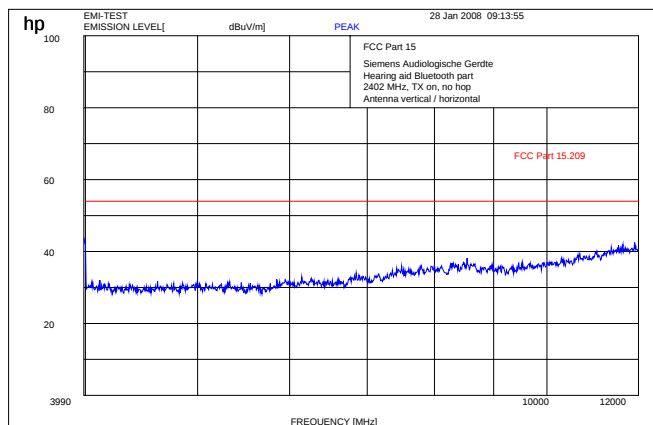
5.15 Spurious Emissions > 30 MHz- radiated (Transmitter) § 15.247 (c)(1)

Modulation: GFSK

Plot: 0.03 - 4 GHz vertical/horizontal (lowest channel)

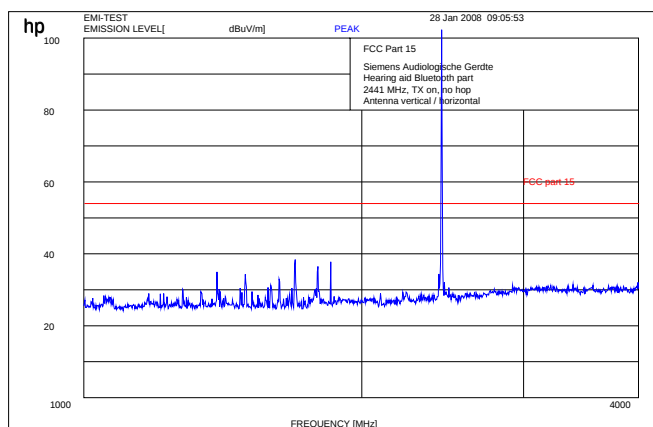
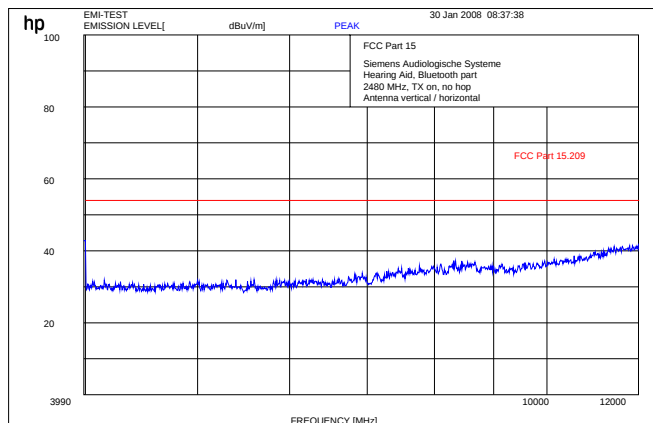


Plot: 4- 12 GHz vertical/horizontal (lowest channel)

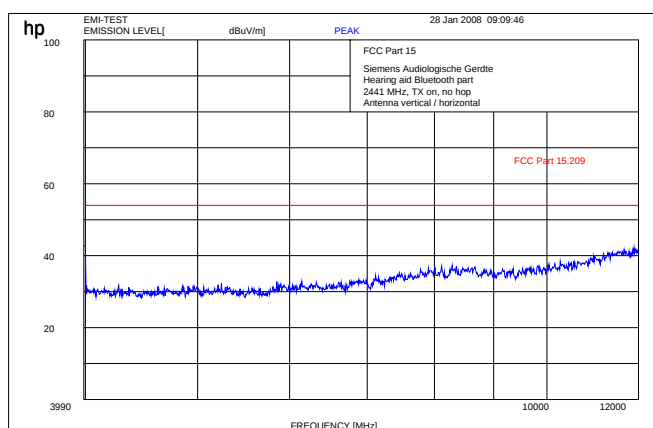


Plot: 12- 25 GHz vertical/horizontal (valid for all channels): no peaks found

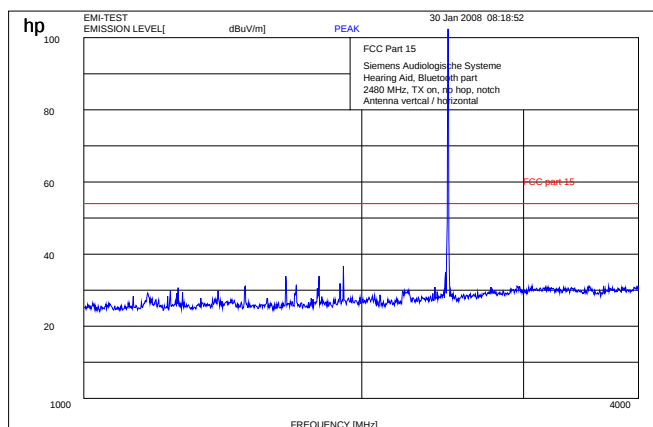
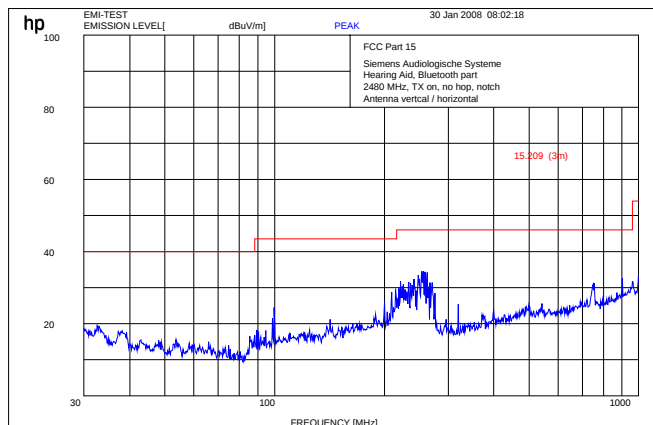
Plot: 0.03 - 4 GHz vertical/horizontal (middle channel)



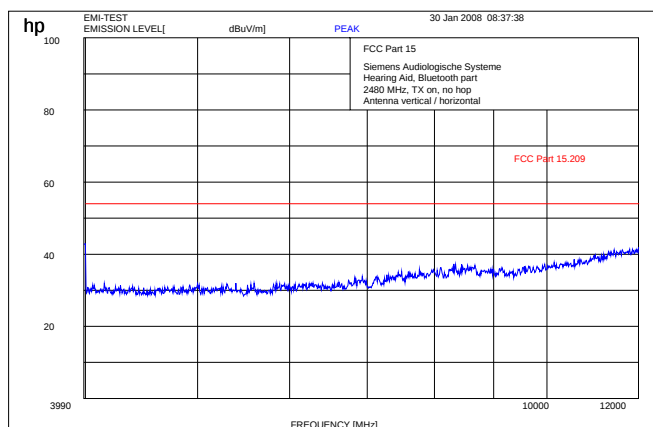
Plot: 4- 12 GHz vertical/horizontal (middle channel)



Plot: 0.03 - 4 GHz vertical/horizontal (highest channel)



Plot: 4- 12 GHz vertical/horizontal (highest channel)



Results:

SPURIOUS EMISSIONS LEVEL (dB μ V/m)								
2402 MHz			2441 MHz			2480 MHz		
F [MHz]	Detector	Level [dB μ V/m]	F [MHz]	Detector	Level [dB μ V/m]	F [MHz]	Detector	Level [dB μ V/m]
No critical peaks detected								
Measurement uncertainty			± 3 dB					

$f < 1$ GHz : RBW/VBW: 100 kHz

$f \geq 1$ GHz : RBW/VBW: 1 MHz

Limits: § 15.247 (c)

In any 100 kHz bandwidth outside the frequency band at least 20dB below the highest level of the desired power. In addition, radiated emissions which fall in the restricted bands, as defined in §15.205(a), must also comply with the radiated emission limits specified in §15.209(a) (see §15.205(c)).

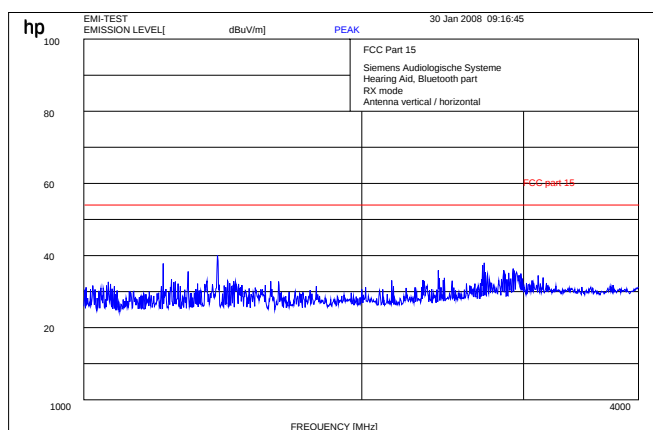
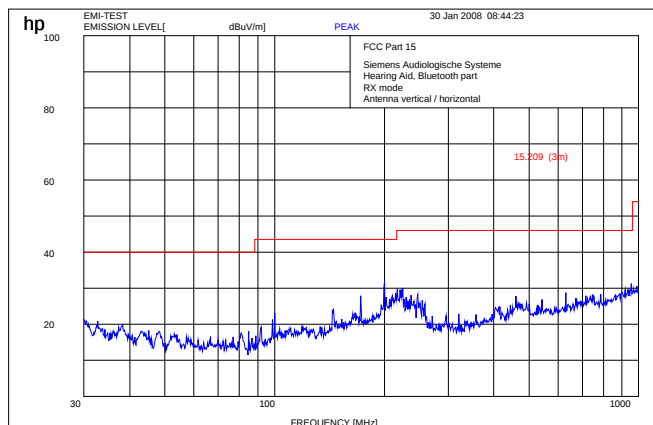
Limits: § 15.209

Frequency [MHz]	Field strength [μ V/m]	Measurement distance (m)
30 - 88	100 (40 dB μ V/m)	3
88 - 216	150 (43.5 dB μ V/m)	3
216 - 960	200 (46 dB μ V/m)	3
above 960	500 (54 dB μ V/m)	3

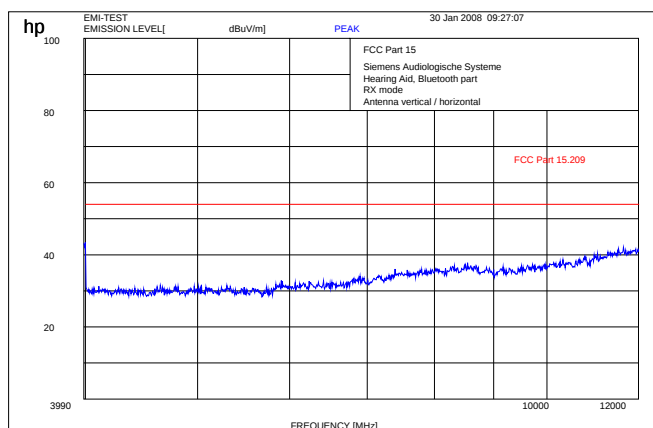
5.16 Spurious Emissions - radiated (Receiver) § 15.109

Modulation: GFSK

Plot: 0.03 - 4 GHz vertical/horizontal (receiver)



Plot: 4- 12 GHz vertical/horizontal (receiver)



Plot: 12- 25 GHz vertical/horizontal (receiver): no peaks found

Spurious Emissions level [dB μ V/m]		
f[MHz]	Detector	Level [dB μ V/m]
No critical peaks detected		
Measurement uncertainty		± 3 dB

f < 1 GHz: RBW/VBW: 100 kHz

f $\geq$ 1GHz : RBW/VBW: 1 MHz

See above plots

Measurement distance see table

Limits: § 15.109

Frequency (MHz)	Field strength (μ V/m)	Measurement distance (m)
30 - 88	100 (40 dB μ V/m)	3
88 - 216	150 (43.5 dB μ V/m)	3
216 - 960	200 (46 dB μ V/m)	3
above 960	500 (54 dB μ V/m)	3

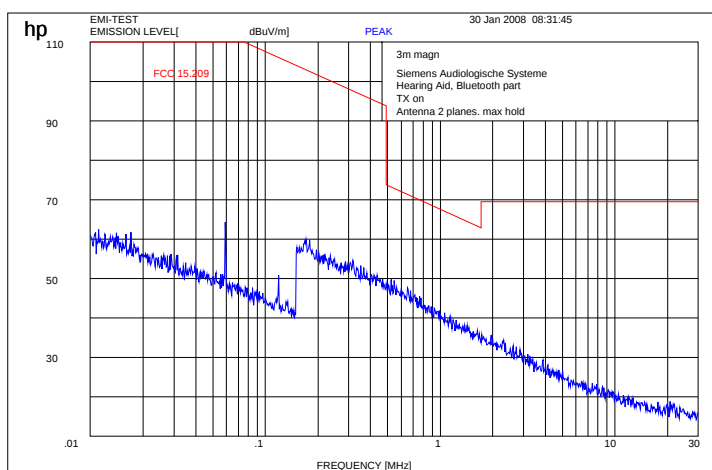
5.17 Spurious Emissions < 30 MHz - Transmitter radiated § 15.209

Modulation: GFSK

Measured at 10 m distance.

Values recalculated with 40 dB/decade according to FCC rules.

Plot 1:

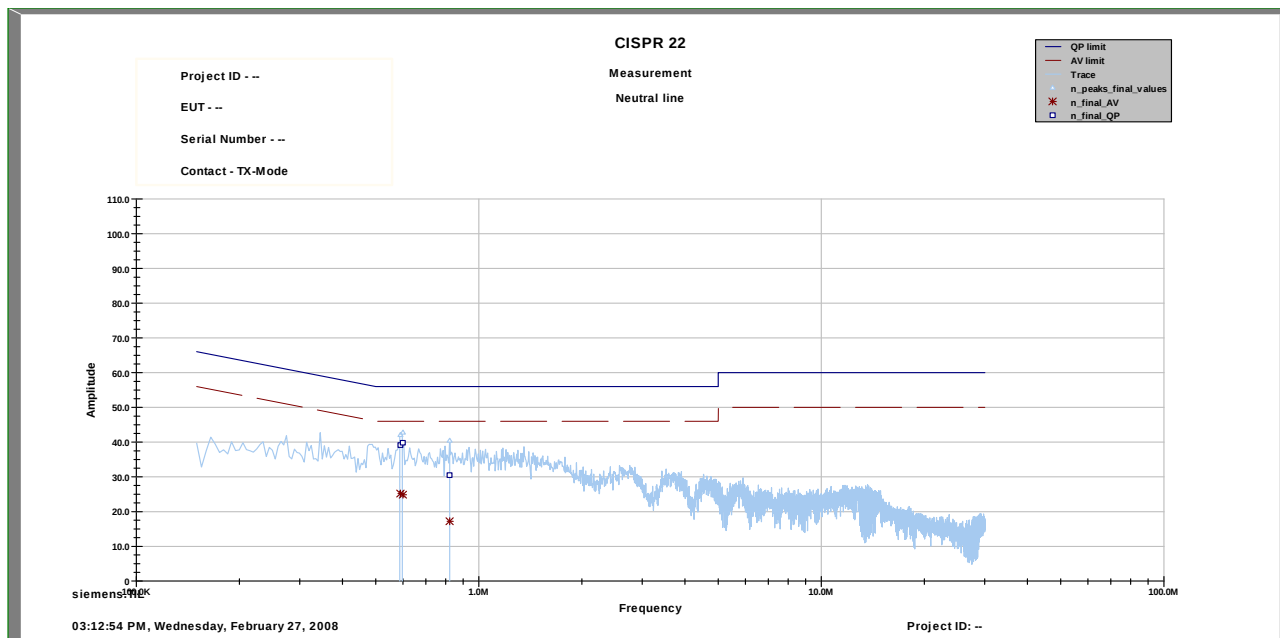


Limits:

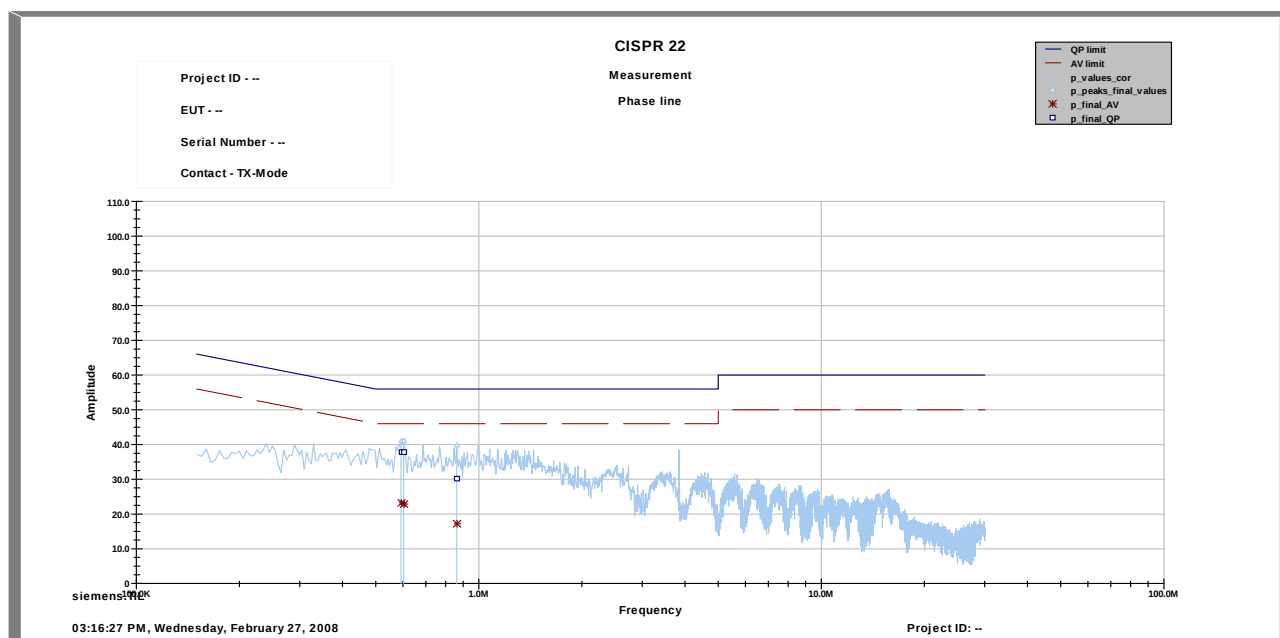
Frequency (MHz)	Field strength ($\mu\text{V/m}$)	Measurement distance (m)
0.009 – 0.490	$2400/F(\text{kHz})$	300
0.490 – 1.705	$24000/F(\text{kHz})$	30
1.705 – 30.0	$30 / 29.5 \text{ dB}\mu\text{V/m}$	30

5.18 Conducted Emissions <30 MHz § 15.107/207

Plot 1:



Plot 2:



Limits :

Under normal test conditions only	See plots
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6 Test equipment and ancillaries used for tests

To simplify the identification on each page of the test equipment used, on each page of the test report, each item of test equipment and ancillaries such as cables are identified (numbered) by the Test Laboratory, below.

Anechoic chamber C:

No	Equipment/Type	Manuf.	Serial Nr.	Inv. No. Cetecom	Last Calibration	Frequency (months)	Next Calibration
1	Anechoic chamber	MWB	87400/02	300000996	Monthly verification		
2	System-Rack 85900	HP I.V.	*	300000222	n.a.		
3	Measurement System 1						
4	Spektrum Analyzer 8566B	HP	2747A05306	300001000	05.10.2006	24	05.10.2008
5	Spektrum Analyzer Display 85662A	HP	2816A16541	300002297	05.10.2006	24	05.10.2008
6	Quasi-Peak-Adapter 85650A	HP	2811A01131	300000999	05.10.2006	24	05.10.2008
7	RF-Preselector 85685A	HP	2837A00779	300000218	08.11.2006	24	08.11.2008
8	PC Vectra VL	HP		300001688	n.a.		
9	Software EMI	HP		300000983	n.a.		
10	Measurement System 2						
11	FSP 30	R&S	100623	ICT 300003464	05.10.2007	24	15.10.2009
12	PC	F+W			n.a.		
13	TILE	TILE			n.a.		
14	Biconical antenna	EMCO	S/N: 860 942/003		Monthly verification (System cal.)		
15	Log. Period. Antenna 3146	EMCO	2130	300001603	Monthly verification (System cal.)		
16	Double Ridged Antenna HP 3115P	EMCO	3088	300001032	Monthly verification (System cal.)		
17	Active Loop Antenna 6502	EMCO	2210	300001015	Monthly verification (System cal.)		
18	Power Supply 6032A	HP	2818A03450	300001040	12.05.2007	36	12.05.2010
19	Busisolator	Kontron		300001056	n.a.		
20	Leitungsteiler 11850C	HP		300000997	Monthly verification (System cal.)		
21	Power attenuator 8325	Byrd	1530	300001595	Monthly verification (System cal.)		
22	Band reject filter WRCG1855/1910	Wainwright	7	300003350	Monthly verification (System cal.)		
23	Band reject filter WRCG2400/2483	Wainwright	11	300003351	Monthly verification (System cal.)		

Signalling Units:

No	Equipment/Type	Manuf.	Serial Nr.	Inv. No. Cetecom	Last Calibration	Frequency (months)	Next Calibration
1	CBT	R&S	100313	300003516	24.10.2006	24	24.10.2008
2	CBT	R&S	100185	300003416	21.02.2006	24	21.02.2008
3	CMU-200	R&S	103992	300003231	27.04.2007	12	27.04.2008
4	CMU-200	R&S	106240	300003321	02.05.2006	24	02.05.2008

SRD Laboratory Room 005:

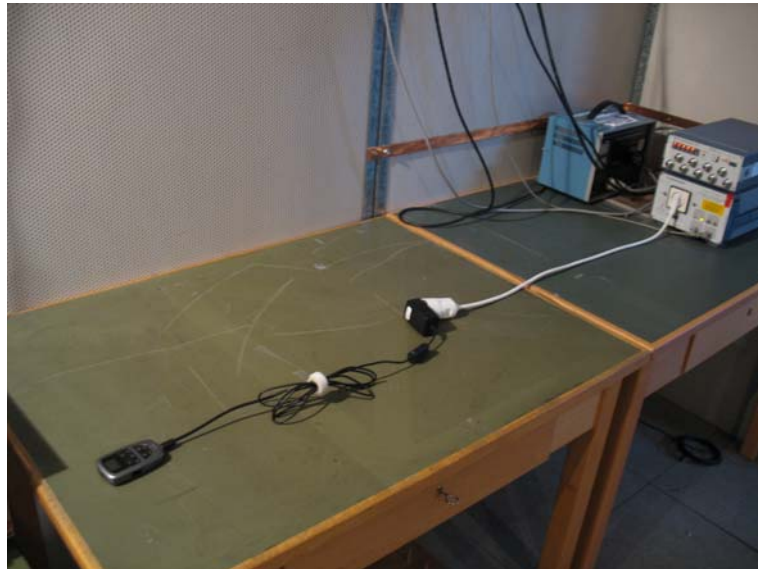
No	Equipment/Type	Manuf.	Serial Nr.	Inv. No. Cetecom	Last Calibration	Frequency (months)	Next Calibration
1	Spektrum Analyzer 8566B	HP	2747A05275	300000219	08.11.2006	24	08.11.2008
2	Spektrum Analyzer Display 85662A	HP	2816A16497	300001690	08.11.2006	24	08.11.2008
3	Quasi-Peak-Adapter 85650A	HP	2811A01135	300000216	08.11.2006	24	08.11.2008
4	Power Supply	Heiden	003202	300001187	12.05.2007	36	12.05.2010
5	Power Supply	Heiden	1701	300001392	12.05.2007	36	12.05.2010

Anechoic chamber F:

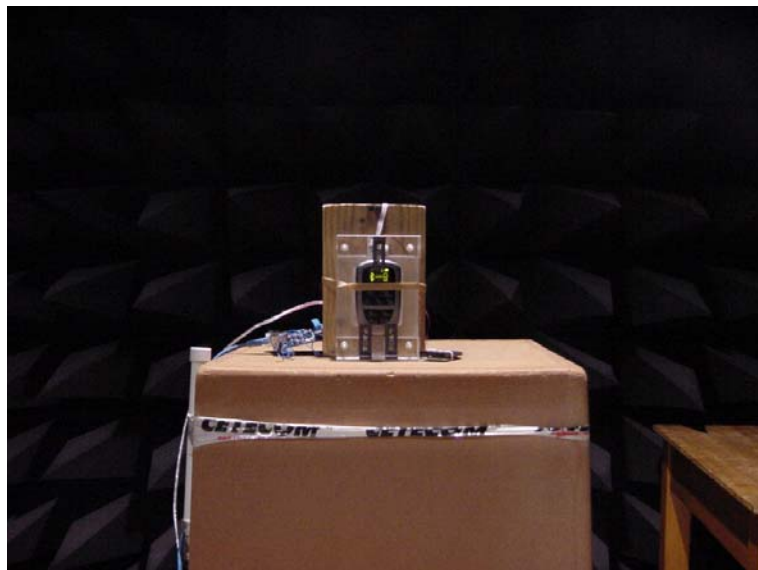
No.	Instrument/Ancillary	Manufacturer	Type	Serial-No.	Internal identification
Radiated emission in chamber F					
F-1	Control Computer	F+W		FW0502032	300003303
F-2	Bilog antenna	Chase	CBL 6112A	2110	300000573
F-3a	Amplifier	Veritech Microwave Inc.	0518C-138	- / -	- / -
F-4b	Switch	HP	3488A	- / -	300000368
F-5	EMI Test receiver	R&S	ESCI	100083	300003312
F-6	Turntable Controller	EMCO	1061 3M	1218	300000661
F-7	Tower Controller	EMCO	1051 Controller	1262	300000625
F-8	Tower	EMCO	1051 Tower	1262	300000625
F-9	Ultra Notch-Filter Rejected band Ch. 62	WRCD		9	
Radiated immunity in chamber F					
F-10	Control Computer	F+W		FW0502032	300003303
F-11	Signal Generator	R&S	SML 03	102519	300003407
F-12	RF-Amplifier	ar	50W1000	12932	300001438
F-13	Directional Coupler	ar	DC 3010	12708	300001428
F-14	Logper Antenna	R&S	HL023A1	323704/016	300001476
F-15	RF-Amplifier	ar	60S1G3	313649	300003410
F-16	Directional Coupler	ar	DC7144A	312786	300003411
F-17	Horn Antenna	ar	AT 4002	19739	300000633
F-18	Power Meter	R&S	NRV	860327/024	F033
F-19	Power sensor	R&S	URV5-Z2	839080/005	300002844.02
F-20	Power sensor	R&S	URV5-Z2	830755/057	F032
Harmonics and flicker in front of chamber F					
F-21	Flicker and Harmonics Test System	Spitzenberger & Spies	PHE4500/B I PHE4500/B II	B5983 B5984	300000210
F-22	Control Unit	Spitzenberger & Spies	STE	B5980	300000210
F-23	Power Amplifier	Spitzenberger & Spies	EP 4500/B	B5976	300000210
F-24	Conect Panel	Spitzenberger & Spies	Conect panel	B5982	300000210
F-25	Power Supply	Spitzenberger & Spies	NT-EP 4500	B3977	300000210
F-26	Additional transformer	Spitzenberger & Spies	UT-EP 4500	B5978	300000210
F-27	Analyzer Reference System	Spitzenberger & Spies	ARS 16/1	A3509 07/0 0205	300003314
F-26	Power Supply	Hewlett Packard	6032 A	2920 A 04466	300000580

7 Photographs of the Test Set-up

Conducted Spurious:



Spurious radiated >1 GHz



Spurious radiated <1 GHz



8 Photographs of the EUT

Photo 1: (Testsample in testfixture)

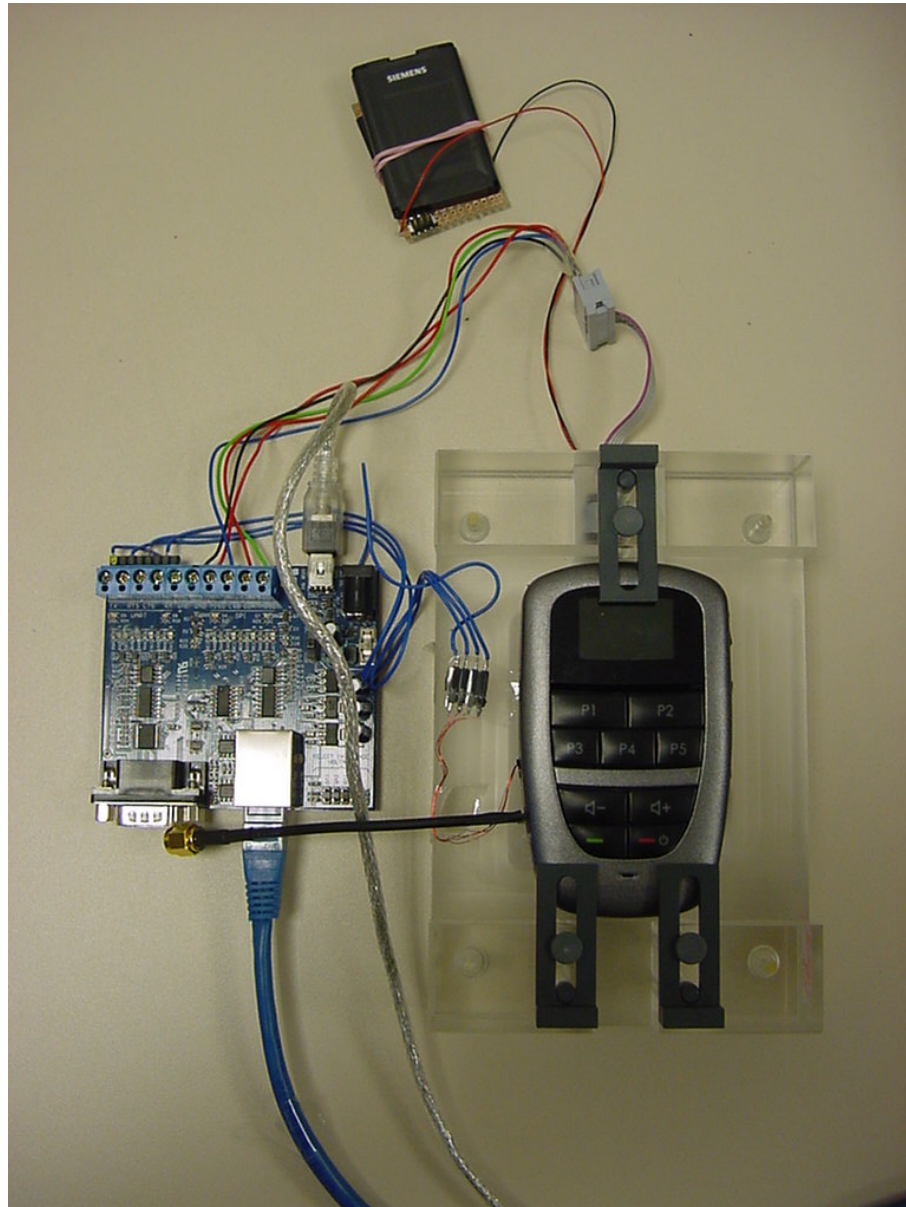


Photo 2: Testsample



Photo 3: Testsample



Photo 4: Testsample

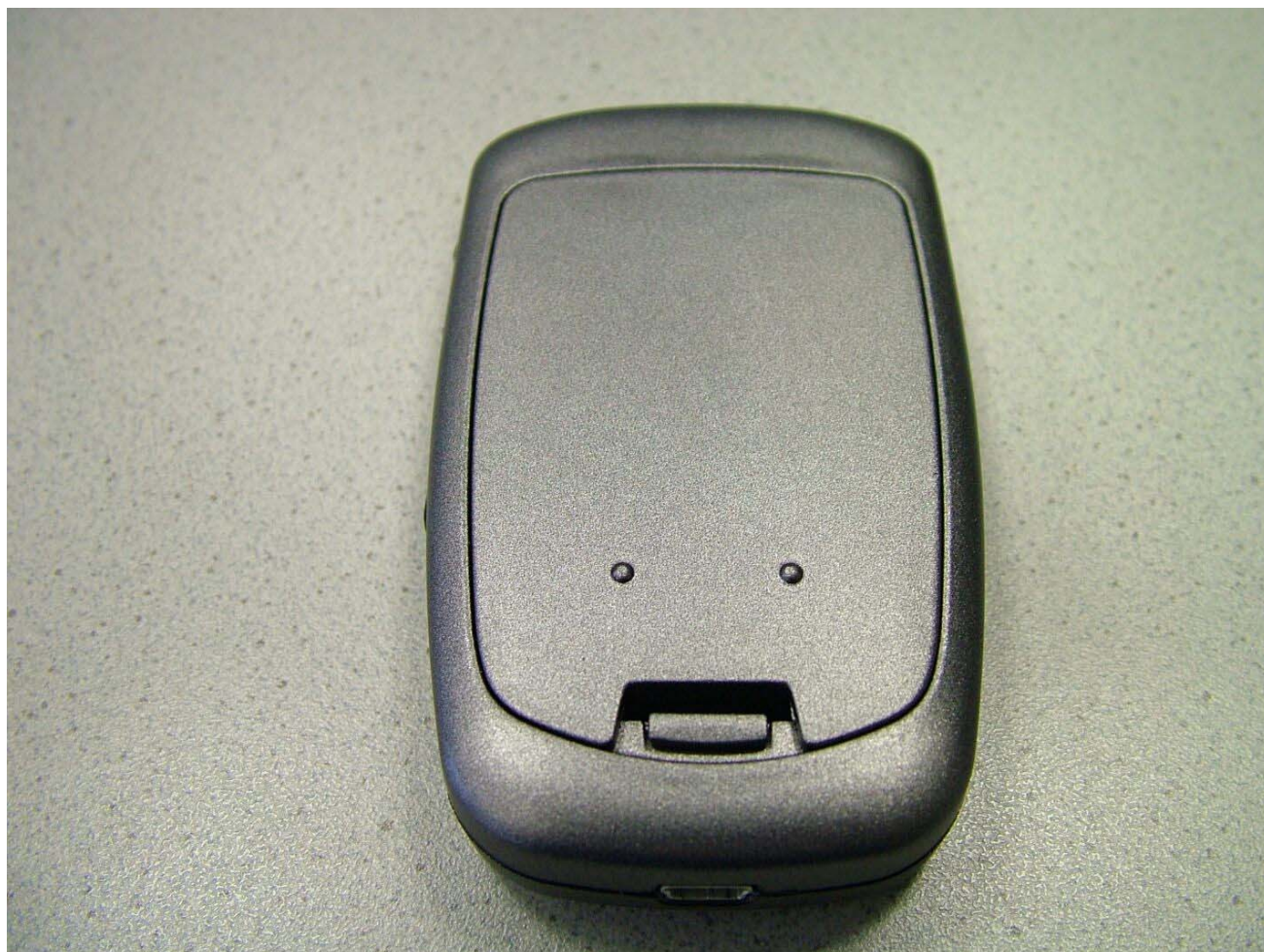


Photo 5: Testsample



Photo 6: Testsample



Photo 7: Testsample

